Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10541784	AUFFRET, ERIC	
Examiner	Art Unit	
Nguyen, Hai V	2618	

		SEARCHED		
Class	<u> </u>	Subclass	Date	Examiner
455	522		02/19/2008	HN

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (See search history printout report)	02/19/2008	HN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examine		

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